

KA5x03xx-SERIES

KA5H0365R, KA5M0365R, KA5L0365R, KA5M0365RN, KA5L0365RN, KA5H0380R, KA5M0380R, KA5L0380R Fairchild Power Switch(FPS)

Features

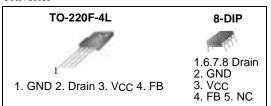
- Precision Fixed Operating Frequency (100/67/50kHz)
- Low Start-up Current(Typ. 100uA)
- Pulse by Pulse Current Limiting
- · Over Current Protection
- Over Voltage Protection (Min. 25V)
- · Internal Thermal Shutdown Function
- Under Voltage Lockout
- Internal High Voltage Sense FET
- · Auto-Restart Mode

Applications

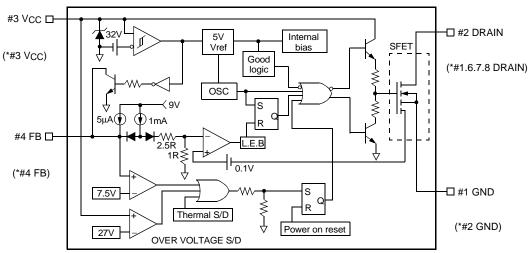
- SMPS for VCR, SVR, STB, DVD & DVCD
- SMPS for Printer, Facsimile & Scanner
- · Adaptor for Camcorder

Description

The Fairchild Power Switch(FPS) product family is specially designed for an off-line SMPS with minimal external components. The Fairchild Power Switch(FPS) consists of a high voltage power SenseFET and a current mode PWM IC. Included PWM controller integrates the fixed frequency oscillator, the under voltage lock-out, the leading edge blanking, the optimized gate turn-on/turn-off driver, the thermal shutdown protection, the over voltage protection, and the temperature compensated precision current sources for the loop compensation and the fault protection circuitry. Compared to a discrete MOSFET and a PWM controller or an RCCsolution, a Fairchild Power Switch(FPS) can reduce the total component count, design size and weight and at the same time increase efficiency, productivity, and system reliability. It has a basic platform well suited for the cost effective design in either a flyback converter or a forward converter



Internal Block Diagram



*Asterisk - KA5M0365RN, KA5L0365RN

Absolute Maximum Ratings

(Ta=25°C, unless otherwise specified)

Characteristic	Symbol	Value	Unit				
KA5H0365R, KA5M0365R, KA5L0365R							
Maximum Drain Voltage	VD,MAX	650	V				
Drain-Gate Voltage (R _{GS} =1MΩ)	VDGR	650	V				
Gate-Source (GND) Voltage	Vgs	±30	V				
Drain Current Pulsed (1)	I _{DM}	12.0	ADC				
Continuous Drain Current (Tc=25°C)	ID	3.0	ADC				
Continuous Drain Current (T _C =100°C)	ID	2.4	ADC				
Single Pulsed Avalanche Energy (2)	EAS	358	mJ				
Maximum Supply Voltage	VCC,MAX	30	V				
Analog Input Voltage Range	VFB	-0.3 to V _{SD}	V				
Total Power Dissipation –	PD	75	W				
Total Fower Dissipation	Derating	0.6	W/°C				
Operating Junction Temperature.	TJ	+160	°C				
Operating Ambient Temperature.	TA	-25 to +85	°C				
Storage Temperature Range.	TSTG	-55 to +150	°C				
KA5H0380R, KA5M0380R, KA5L0380R							
Maximum Drain Voltage	VD,MAX	800	V				
Drain-Gate Voltage (R _{GS} =1MΩ)	VDGR	800	V				
Gate-Source (GND) Voltage	Vgs	±30	V				
Drain Current Pulsed (1)	IDM	12.0	ADC				
Continuous Drain Current (Tc=25°C)	ID	3.0	ADC				
Continuous Drain Current (Tc=100°C)	ID	2.1	ADC				
Single Pulsed Avalanche Energy (2)	EAS	95	mJ				
Maximum Supply Voltage	VCC,MAX	30	V				
Analog Input Voltage Range	VFB	-0.3 to V _{SD}	V				
Total Power Dissipation -	PD	75	W				
Total Fower Dissipation	Derating	0.6	W/°C				
Operating Junction Temperature.	TJ	+160	°C				
Operating Ambient Temperature.	TA	-25 to +85	°C				
Storage Temperature Range.	TSTG	-55 to +150	°C				

Note:

^{1.} Repetitive rating: Pulse width limited by maximum junction temperature

^{2.} L = 51mH, starting Tj = 25° C

^{3.} L = $13\mu H$, starting Tj = $25^{\circ}C$

Absolute Maximum Ratings

(Ta=25°C, unless otherwise specified)

Characteristic	Symbol	Value	Unit					
KA5M0365RN, KA5L0365RN								
Maximum Drain Voltage	VD,MAX	650	V					
Drain-Gate Voltage (R _{GS} =1MΩ)	VDGR	650	V					
Gate-Source (GND) Voltage	Vgs	±30	V					
Drain Current Pulsed (1)	IDM	12.0	ADC					
Continuous Drain Current (Ta=25°C)	ID	0.42	ADC					
Continuous Drain Current (Ta=100°C)	ID	0.28	ADC					
Single Pulsed Avalanche Energy (2)	EAS	127	mJ					
Maximum Supply Voltage	VCC,MAX	30	V					
Analog Input Voltage Range	VFB	-0.3 to V _{SD}	V					
Total Dawer Dissipation	PD	1.56	W					
Total Power Dissipation	Derating	0.0125	W/°C					
Operating Junction Temperature.	TJ	+160	°C					
Operating Ambient Temperature.	TA	-25 to +85	°C					
Storage Temperature Range.	TSTG	-55 to +150	°C					

Note:

^{1.} Repetitive rating: Pulse width limited by maximum junction temperature

^{2.} L = 51mH, starting Tj = 25° C

^{3.} L = $13\mu H$, starting Tj = $25^{\circ}C$

Electrical Characteristics (SenseFET Part)

(Ta = 25°C unless otherwise specified)

Parameter	Symbol	Condition	Min.	Тур.	Max.	Unit
KA5H0365R, KA5M0365R, KA5L0365R						
Drain-Source Breakdown Voltage	BVDSS	VGS=0V, ID=50μA	650	-	-	V
		V _{DS} =Max. Rating, V _{GS} =0V	-	-	50	μΑ
Zero Gate Voltage Drain Current	IDSS	V _{DS} =0.8Max. Rating, V _{GS} =0V, T _C =125°C	-	-	200	μΑ
Static Drain-Source on Resistance (Note)	RDS(ON)	VGS=10V, ID=0.5A	-	3.6	4.5	Ω
Forward Transconductance (Note)	gfs	V _{DS} =50V, I _D =0.5A	2.0	-	-	S
Input Capacitance	Ciss)/ O)/)/ OF)/	-	720	-	pF
Output Capacitance	Coss	VGS=0V, VDS=25V, f=1MHz	-	40	-	
Reverse Transfer Capacitance	Crss	1-11/11/2	-	40	-	
Turn On Delay Time	td(on)	V _{DD} =0.5BV _{DSS} , I _D =1.0A	-	150	-	
Rise Time	tr	(MOSFET switching	-	100	-	nS
Turn Off Delay Time	td(off)	time is essentially independent of	-	150	-	
Fall Time	tf	operating temperature)	-	42	-	
Total Gate Charge (Gate-Source+Gate-Drain)	Qg	VGS=10V, ID=1.0A, VDS=0.5BVDSS (MOSFET	-	-	34	nC
Gate-Source Charge	Qgs	switching time is essentially	-	7.3	-	
Gate-Drain (Miller) Charge	Qgd	independent of operating temperature)	-	13.3	-	
KA5H0380R, KA5M0380R, KA5L0380R		<u>I</u>				
Drain-Source Breakdown Voltage	BVDSS	V _G S=0V, I _D =50μA	800	-	-	V
		VDS=Max. Rating, VGS=0V	-	-	250	μΑ
Zero Gate Voltage Drain Current	IDSS	V _{DS} =0.8Max. Rating, V _{GS} =0V, T _C =125°C	-	-	1000	μΑ
Static Drain-Source on Resistance (Note)	RDS(ON)	VGS=10V, ID=0.5A	-	4.0	5.0	Ω
Forward Transconductance (Note)	gfs	VDS=50V, ID=0.5A	1.5	2.5	-	S
Input Capacitance	Ciss		-	779	-	
Output Capacitance	Coss	VGS=0V, VDS=25V, f=1MHz	-	75.6	-	pF
Reverse Transfer Capacitance	Crss	1-11/11/12	-	24.9	-	
Turn On Delay Time	td(on)	VDD=0.5BVDSS, ID=1.0A	-	40	-	
Rise Time	tr	(MOSFET switching	-	95	-	nS
Turn Off Delay Time	td(off)	time is essentially independent of	-	150	-	
Fall Time	tf	operating temperature)	-	60	-	
Total Gate Charge (Gate-Source+Gate-Drain)	Qg	V _G S=10V, I _D =1.0A, V _D S=0.5BV _D SS (MOSFET	-	-	34	
Gate-Source Charge	Qgs	switching time is	-	7.2	-	nC
Gate-Drain (Miller) Charge	Qgd	essentially independent of operating temperature)	-	12.1	-	

Note:

1. Pulse test: Pulse width $\leq 300 \mu S, \, duty \leq 2\%$

2.
$$S = \frac{1}{R}$$

Electrical Characteristics (SenseFET Part)

(Ta = 25°C unless otherwise specified)

Parameter	Symbol	Condition	Min.	Тур.	Max.	Unit	
KA5M0365RN, KA5L0365RN							
Drain-Source Breakdown Voltage	BVDSS	VGS=0V, ID=50μA	650	-	-	V	
		V _{DS} =Max. Rating, V _{GS} =0V	-	-	50	μΑ	
Zero Gate Voltage Drain Current	IDSS	V _{DS} =0.8Max. Rating, V _{GS} =0V, T _C =125°C	-	-	200	μΑ	
Static Drain-Source on Resistance (Note)	RDS(ON)	VGS=10V, ID=0.5A	-	3.6	4.5	Ω	
Forward Transconductance (Note)	gfs	V _{DS} =50V, I _D =0.5A	2.0	-	-	S	
Input Capacitance	Ciss	0.777	-	314.9	-	pF	
Output Capacitance	Coss	VGS=0V, VDS=25V, f=1MHz	-	47	-		
Reverse Transfer Capacitance	Crss	1-111112	-	9	-		
Turn On Delay Time	td(on)	V _{DD} =0.5BV _{DSS} , I _D =1.0A	-	11.2	-		
Rise Time	tr	(MOSFET switching time is essentially	-	34	-	nS	
Turn Off Delay Time	td(off)	independent of	-	28.2	-	113	
Fall Time	tf	operating temperature)	-	32	-		
Total Gate Charge (Gate-Source+Gate-Drain)	Qg	VGS=10V, ID=1.0A, VDS=0.5BVDSS (MOSFET			11.93		
Gate-Source Charge	Qgs	switching time is	-	1.95	-	nC	
Gate-Drain (Miller) Charge	Qgd	essentially independent of operating temperature)		6.85		l	

Note:

1. Pulse test: Pulse width $\leq 300 \mu S, \, duty \leq 2\%$

$$^2. \ S \ = \ \frac{1}{R}$$

Electrical Characteristics (Control Part) (Continued)

(Ta = 25°C unless otherwise specified)

Characteristic	Symbol	Test condition	Min.	Тур.	Max.	Unit		
UVLO SECTION								
Start Threshold Voltage	VSTART	VFB=GND	14	15	16	V		
Stop Threshold Voltage	VSTOP	V _{FB} =GND	8.4	9	9.6	V		
OSCILLATOR SECTION								
Initial Accuracy	Fosc	KA5H0365R KA5H0380R	90	100	110	kHz		
Initial Accuracy	Fosc	KA5M0365R KA5M0365RN KA5M0380R	61	67	73	kHz		
Initial Accuracy	Fosc	KA5L0365R KA5L0365RN KA5L0380R	45	50	55	kHz		
Frequency Change With Temperature (2)	-	-25°C≤Ta≤+85°C	-	±5	±10	%		
Maximum Duty Cycle	Dmax	KA5H0365R KA5H0380R	62	67	72	%		
Maximum Duty Cycle	Dmax	KA5M0365R KA5M0365RN KA5M0380R KA5L0365R KA5L0365RN KA5L0380R	72	77	82	%		
FEEDBACK SECTION								
Feedback Source Current	IFB	Ta=25°C, 0V <u><</u> Vfb <u><</u> 3V	0.7	0.9	1.1	mA		
Shutdown Feedback Voltage	VsD	Vfb <u>></u> 6.5V	6.9	7.5	8.1	V		
Shutdown Delay Current	Idelay	Ta=25°C, 5V≤Vfb≤VsD	4	5	6	μΑ		
REFERENCE SECTION								
Output Voltage (1)	Vref	Ta=25°C	4.80	5.00	5.20	V		
Temperature Stability (1)(2)	Vref/∆T	-25°C≤Ta≤+85°C	-	0.3	0.6	mV/°C		
CURRENT LIMIT(SELF-PROTECTION)SECTION								
Peak Current Limit	Iover	Max. inductor current	1.89	2.15	2.41	Α		
PROTECTION SECTION								
Over Voltage Protection	Vovp	V _{CC≥} 24V	25	27	29	V		
Thermal Shutdown Temperature (Tj) (1)	TSD	-	140	160	-	°C		
TOTAL STANDBY CURRENT SECTION								
Start-up Current	ISTART	V _{CC} =14V	-	100	170	μΑ		
Operating Supply Current (Control Part Only)	lop	VCC <u><</u> 28	-	7	12	mA		

Note:

- 1. These parameters, although guaranteed, are not 100% tested in production
- 2. These parameters, although guaranteed, are tested in EDS(water test) process

Typical Performance Characteristics(SenseFET part)

(KA5H0365R, KA5M0365R, KA5L0365R)

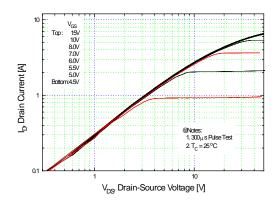


Figure 1. Output Characteristics

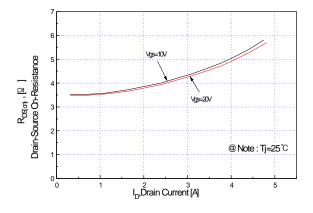


Figure 3. On-Resistance vs. Drain Current

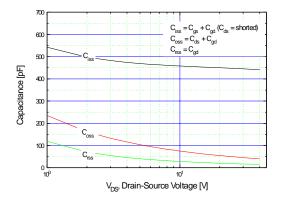


Figure 5. Capacitance vs. Drain-Source Voltage

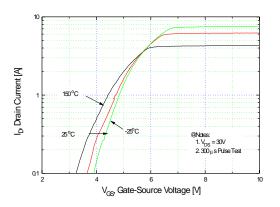


Figure 2. Transfer Characteristics

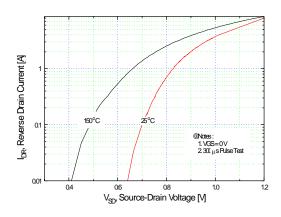


Figure 4. Source-Drain Diode Forward Voltage

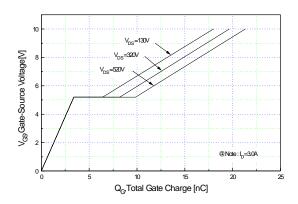


Figure 6. Gate Charge vs. Gate-Source Voltage

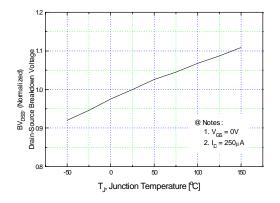


Figure 7. Breakdown Voltage vs. Temperature

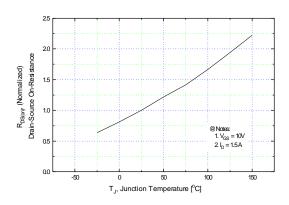


Figure 8. On-Resistance vs. Temperature

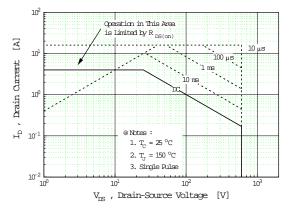


Figure 9. Max. Safe Operating Area

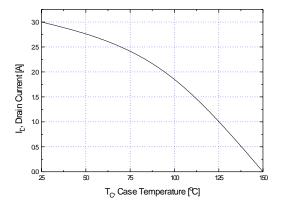


Figure 10. Max. Drain Current vs. Case Temperature

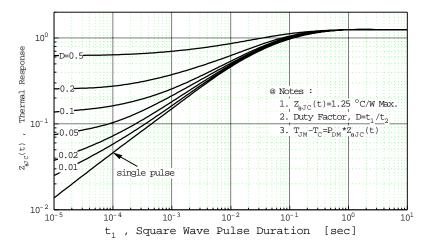


Figure 11. Thermal Response

(KA5H0380R, KA5M0380R, KA5L0380R)

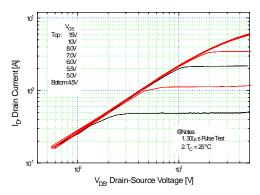


Figure 1. Output Characteristics

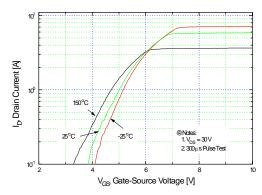


Figure 2. Thansfer Characteristics

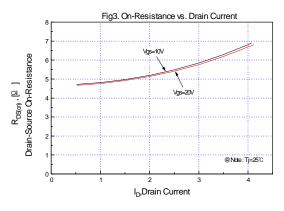


Figure 3. On-Resistance vs. Drain Current

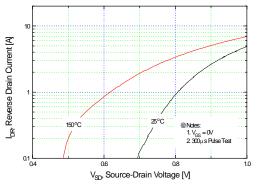


Figure 4. Source-Drain Diode Forward Voltage

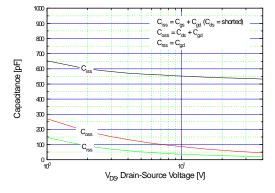


Figure 5. Capacitance vs. Drain-Source Voltage

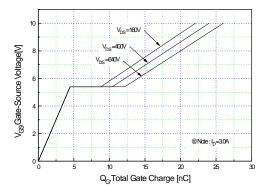


Figure 6. Gate Charge vs. Gate-Source Voltage

(KA5H0380R, KA5M0380R, KA5L0380R)

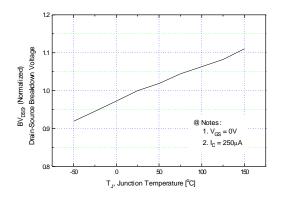


Figure 7. Breakdown Voltage vs. Temperature

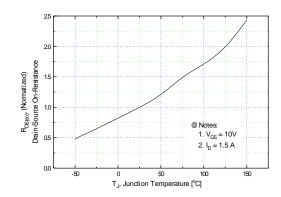


Figure 8. On-Resistance vs. Temperature

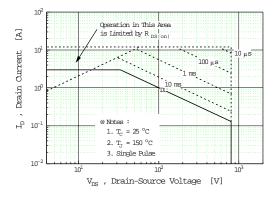


Figure 9. Max. Safe Operating Area

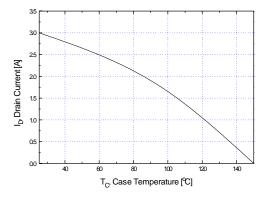


Figure 10. Max. Drain Current vs. Case Temperature

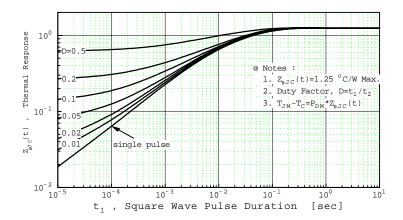


Figure 11. Thermal Response

Typical Performance Characteristics(SenseFET part) (Continued)

(KA5M0365RN, KA5L0365RN)

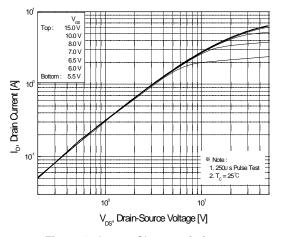


Figure 1. Output Characteristics

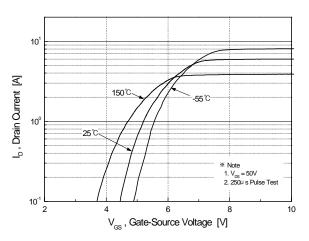


Figure 2. Transfer Characteristics

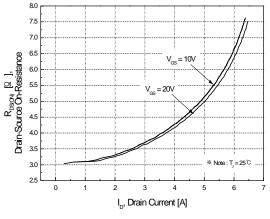


Figure 3. On-Resistance vs. Drain Current

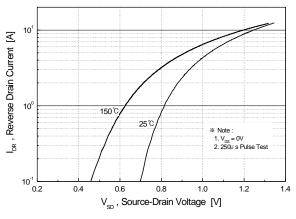


Figure 4. Source-Drain Diode Forward Voltage

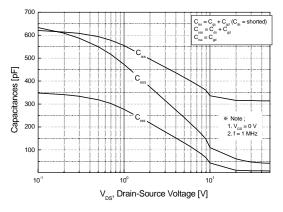


Figure 5. Capacitance vs. Drain-Source Voltage

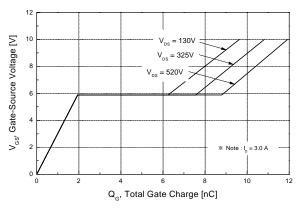
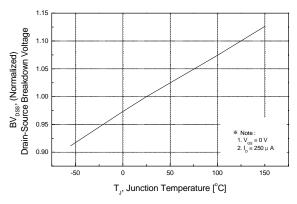


Figure 6. Gate Charge vs. Gate-Source Voltage

(KA5M0365RN, KA5L0365RN)



2.5

(Nomalized)

2.5

(Nomalized)

1.5

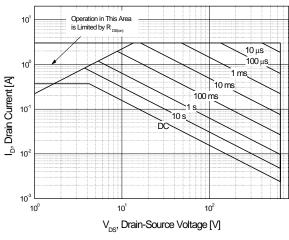
(Nomalized)

1.0

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Figure 7. Breakdown Voltage vs. Temperature

Figure 8. On-Resistance vs. Temperature



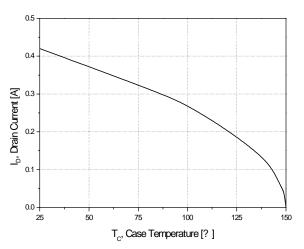


Figure 9. Max. Safe Operating Area

Figure 10. Max. Drain Current vs. Case Temperature

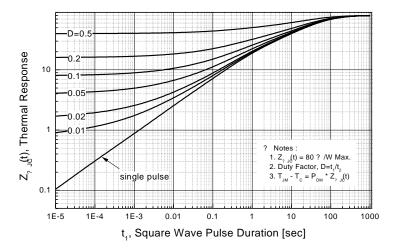


Figure 11. Thermal Response

Typical Performance Characteristics (Control Part) (Continued)

(These characteristic graphs are normalized at Ta = 25°C)

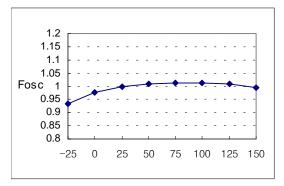


Figure 1. Operating Frequency

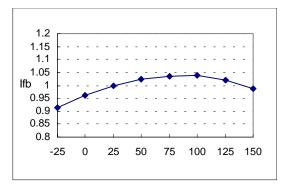


Figure 2. Feedback Source Current

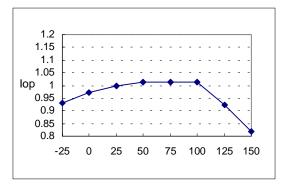


Figure 3. Operating Supply Current

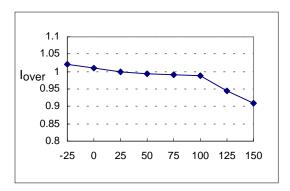


Figure 4. Peak Current Limit

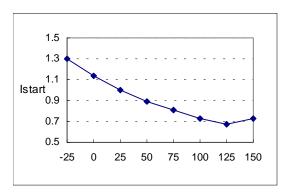


Figure 5. Start up Current

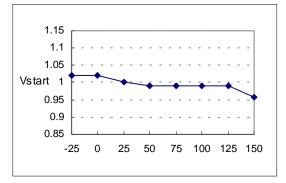


Figure 6. Start Threshold Voltage

(These characteristic graphs are normalized at Ta = 25°C)

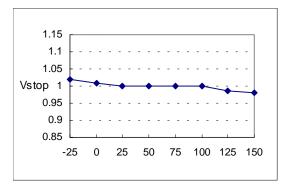
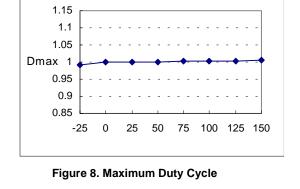


Figure 7. Stop Threshold Voltage



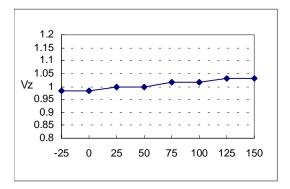


Figure 9. VCC Zener Voltage

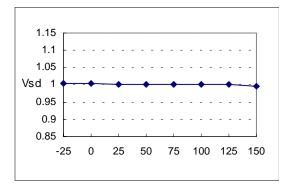


Figure 10. Shutdown Feedback Voltage

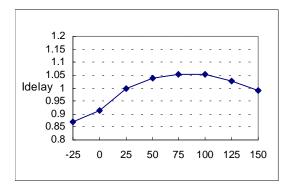


Figure 11. Shutdown Delay Current

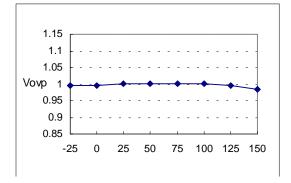


Figure 12. Over Voltage Protection

(These characteristic graphs are normalized at $Ta = 25^{\circ}C$)

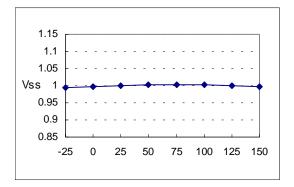


Figure 13. Soft Start Voltage

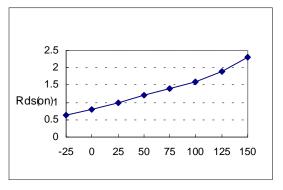
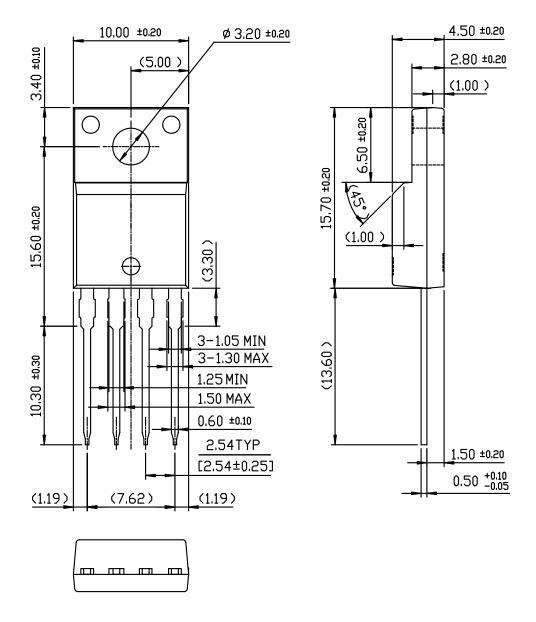


Figure 14. Static Drain-Source on Resistance

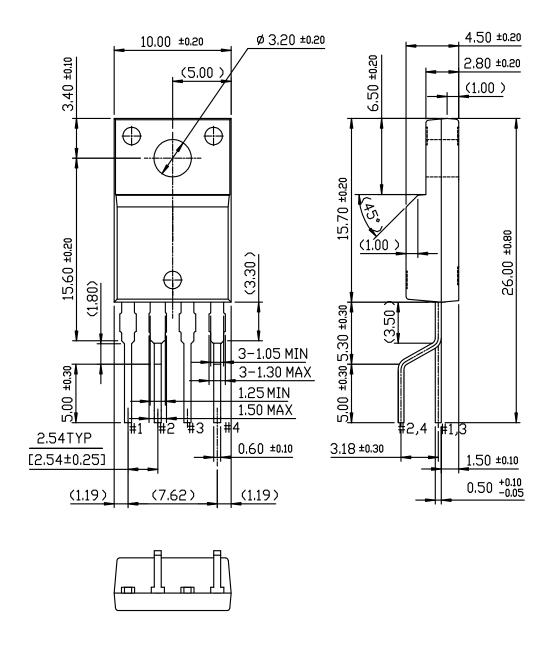
Package Dimensions

TO-220F-4L



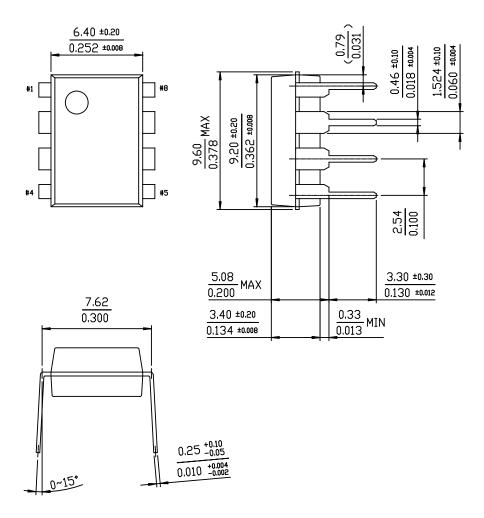
Package Dimensions (Continued)

TO-220F-4L(Forming)



Package Dimensions (Continued)

8-DIP



Ordering Information

Product Number	Package	Marking Code	BVDSS	Fosc	RDS(on)	
KA5H0365RTU	TO-220F-4L	5H0365R	650V	100kHz	3.6Ω	
KA5H0365RYDTU	TO-220F-4L(Forming)	311030313	030 V	TOOKITZ	3.052	
KA5M0365RTU	TO-220F-4L	5M0365R	650V	67kHz	3.6Ω	
KA5M0365RYDTU	TO-220F-4L(Forming)	31V10303K	650 V	07KHZ	3.052	
KA5L0365RTU	TO-220F-4L	5L0365R	650V	50kHz	3.6Ω	
KA5L0365RYDTU	TO-220F-4L(Forming)	3L0303K	650 V	SUKHZ	3.022	
KA5M0365RN	8-DIP	5M0365R	650V	67kHz	3.6Ω	
KA5L0365RN	8-DIP	5L0365R	650V	50kHz	3.6Ω	
Product Number	Package	Marking Code	BVDSS	Fosc	R _{DS(on)}	
KA5H0380RTU	TO-220F-4L	5H0380R	800V	100kHz	4.6Ω	
KA5H0380RYDTU	TO-220F-4L(Forming)	3H0360K	800 V	TOOKHZ	4.012	
KA5M0380RTU	TO-220F-4L	5M0380R	800V	67kHz	4.6Ω	
KA5M0380RYDTU	TO-220F-4L(Forming)	SIVIUSOUR	000 V	U/ KFIZ	4.022	
KA5L0380RTU	TO-220F-4L	5L0380R	800V	50kHz	4.6Ω	
KA5L0380RYDTU	TO-220F-4L(Forming)	JLUSOUK	000 v	JUNIZ	4.052	

TU :Non Forming Type YDTU : Forming type

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- A critical component in any component of a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

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